Search Notes			
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Application/Control No.		Applicant(s)/Patent under Reexamination		
1	10/757,901	OIKAWA ET AL.		
Ī	Examiner	Art Unit		
1	Alain I Rashore	1762		

SEARCHED			
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previous search updated	2/21/2006	АВ
EAST (attached)	2/21/2006	AB
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